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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/781,420	02/18/2004	Rajesh Bhaskar	13641-238701	3050
79338 KENYON & K	7590 10/09/200 CENYON LLP	EXAMINER		
1500 K STREE		LEE, MICHAEL		
WASHINGTO	N, DC 20005-1257		ART UNIT	PAPER NUMBER
			2622	
			MAIL DATE	DELIVERY MODE
			10/09/2008	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.



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APPLICATION NO./ CONTROL NO.	FILING DATE	FIRST NAMED INVENTOR / PATENT IN REEXAMINATION	ATTORNEY DOCKET NO.
10781420	2/18/04	BHASKAR ET AL.	13641-238701

KENYON & KENYON LLP 1500 K STREET, NW WASHINGTON, DC 20005-1257

EXAMINER					
M. Lee					
ART UNIT	PAPER				
2622	20081002				

DATE MAILED:

Please find below and/or attached an Office communication concerning this application or proceeding.

## Commissioner for Patents

The oath or declaration is defective. A new oath or declaration in compliance with 37 CFR 1.67(a) identifying this
application by application number and filing date is required. See MPEP §§ 602.01 and 602.02.
 The oath or declaration is defective because:

The full name of inventor, Sudheesh A.S. (family name and at least one given name together with any initial) has not been set forth.

37 CFR 1.63(a) (2) requires that each inventor be identified by full name, including the family name, and at least one given name without abbreviation together with any other given name or initial in the oath or declaration.

The period for reply of one MONTH set in said Office Action is restarted to begin with the mailing date of this letter.

/Sinh N Tran/ Supervisory Patent Examiner, Art Unit 2615 /M. Lee/ Primary Examiner, Art Unit 2622